

Joint ICTP-IAEA Advanced Workshop on High Sensitivity 2D & 3D  
Characterisation and Imaging with Ion Beams | (smr 2856)

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## Presentation of the TwinMic beamline

*Wednesday, 28 September 2016 16:30 (1:00)*

### Content

### Summary

**Presenter(s)** : GIANONCELLI, Alessandra (Elettra Sincrotrone Trieste)

**Session Classification** : DAY 3